

# DIN EN ISO 21363:2022-03 (E)

## Nanotechnologies - Measurements of particle size and shape distributions by transmission electron microscopy (ISO 21363:2020)

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<b>Contents</b>	<b>Page</b>
<b>European foreword</b> .....	<b>4</b>
<b>Foreword</b> .....	<b>5</b>
<b>Introduction</b> .....	<b>6</b>
<b>1 Scope</b> .....	<b>7</b>
<b>2 Normative references</b> .....	<b>7</b>
<b>3 Terms, definitions and symbols</b> .....	<b>7</b>
3.1 Core terms — Particles .....	7
3.2 Core terms — Image capture and analysis .....	10
3.3 Core terms — Statistical symbols and definitions .....	11
3.4 Core terms — Measurands .....	13
3.5 Core terms — Metrology .....	16
3.6 Core terms — Transmission electron microscopy .....	19
3.7 Statistical symbols, measurands and descriptors .....	20
3.7.1 Statistical symbols .....	20
3.7.2 Measurands and descriptors .....	20
<b>4 Stakeholder needs for TEM measurement procedures</b> .....	<b>21</b>
<b>5 Sample preparation</b> .....	<b>22</b>
5.1 General .....	22
5.2 Sample sources .....	23
5.3 Use a representative sample .....	23
5.3.1 General .....	23
5.3.2 Powder samples .....	23
5.3.3 Nanoparticle dispersions in liquids .....	23
5.4 Minimize particle agglomeration in the sample dispersion .....	24
5.5 Selection of the mounting support .....	24
<b>6 Instrument factors</b> .....	<b>24</b>
6.1 Instrument set-up .....	24
6.2 Calibration .....	25
6.2.1 General .....	25
6.2.2 Calibration standards .....	25
6.2.3 General calibration procedure .....	25
6.3 Setting TEM operating conditions for calibration .....	27
<b>7 Image capture</b> .....	<b>28</b>
7.1 General .....	28
7.2 Setting a suitable operating magnification .....	28
7.3 Minimum particle area .....	29
7.4 Number of particles to count for particle size and shape distributions .....	29
7.5 Uniform background .....	30
7.6 Measurement procedure .....	30
7.6.1 General .....	30
7.6.2 Developing a test sample .....	31
7.6.3 Effects of magnification .....	31
7.6.4 Frames (micrographs) .....	31
7.7 Revision of image capture protocols .....	31
<b>8 Particle analysis</b> .....	<b>31</b>

8.1	General	31
8.2	Individual particle analysis	31
8.3	Automated particle analysis	32
8.4	Example — Automated particle analysis procedure	32
<b>9</b>	<b>Data analysis</b>	<b>33</b>
9.1	General	33
9.2	Raw data triage — Detecting touching particles, unselected particles, artefacts and contaminants	33
9.3	Data quality assessment — Repeatability, intermediate precision and reproducibility	34
9.4	Fitting distributions to data	36
9.5	Assessing measurement uncertainty for samples under repeatability, intermediate precision or reproducibility conditions	37
9.5.1	Grand statistics for fitted parameters — Three or more datasets	37
9.5.2	Measurement uncertainty of fitted parameters	37
9.5.3	Example — Measurement uncertainty for a size descriptor	38
9.6	Bivariate analysis	38
<b>10</b>	<b>Reporting</b>	<b>39</b>
	<b>Annex A (informative) Case studies overview</b>	<b>42</b>
	<b>Annex B (informative) Discrete spheroidal nanoparticles</b>	<b>44</b>
	<b>Annex C (informative) Size mixture</b>	<b>47</b>
	<b>Annex D (informative) Shape mixture</b>	<b>59</b>
	<b>Annex E (informative) Amorphous aggregates</b>	<b>64</b>
	<b>Annex F (informative) Nanocrystalline aggregates</b>	<b>68</b>
	<b>Annex G (informative) Nanofibres with irregular cross-sections</b>	<b>72</b>
	<b>Annex H (informative) Nanoparticles with specific crystal habits</b>	<b>79</b>
	<b>Bibliography</b>	<b>86</b>